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Dynamics in Bi(III)-containing Apatite-Type Oxide Ion Conductors: A Combined Computational and Experimental Study

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Supplementary Information



Fig. S1: Rietveld refinement of $Bi_2La_8Ge_6O_{27}$ carried out using the structural model of Tate et al.¹ and laboratory X-ray diffraction data, confirming the purity of the sample used for the neutron scattering experiment. The observed pattern is shown in blue, calculated in red and the difference curve in grey.





Bonded Oxygen	Bi Site 1		Bi Site 2		Bi Site 3		Bi Site 4	
	La-O Bond Population	Bi-O Bond Population						
01	0.14	0.02	0.13	0.01	0.12	0.03	0.16	0.03
02	0.17	0.11	0.14	0.04	0.15	0.05	0.19	0.11
O3a	0.15	0.07	0.22	0.09	0.23	0.06	0.15	0.08
O3b	0.15	0.14	0.21	0.19	0.20	0.16	0.21	0.14
O3c	0.19	0.22	0.30	0.23	0.29	0.28	0.19	0.21
O3d	0.27	0.13	0.21	0.13	0.22	0.17	0.26	0.14
04	0.33	0.24	0.36	0.24	0.33	0.24	0.38	0.22

 $\textbf{Table S1:} The Mulliken bond populations and M-O bond lengths for four A2 sites containing La in La_{10}Ge_{6}O_{27} and Bi in Bi_{2}La_{8}Ge_{6}O_{27}$



Fig. S3: Distribution of Mullikan populations for the Bi atoms in $Bi_2La_8Ge_6O_{27}$ (blue) and the La atoms on the equivalent sites in $La_{10}Ge_6O_{27}$ (yellow).

References

1.

M. Tate, D. Blom, M. Avdeev, H. Brand, G. McIntyre, T. Vogt and I. Evans, Advanced Functional Materials, 2017, 27.